

Physics of Surfaces and Thin Films, Materials Physics, Solid State Physics, Atomic and Molecular Physics, Quantum Mechanics

Final competences

- 1 Describe in a transparent way the physical working principles of the deposition techniques that have been addressed in depth, and select deposition conditions for a given application.
- 2 Understand the origin of stress in thin films.
- 3 Design a strategy to study thin film properties based on the acquired knowledge on thin film characterization techniques, their principle of operation, capabilities and limitations.
- 4 Recognize for a number of selected applications the function of the thin film(s).

Conditions for credit contract

Access to this course unit via a credit contract is determined after successful competences assessment

Conditions for exam contract

This course unit cannot be taken via an exam contract

Teaching methods

Seminar, Lecture, Practical, Independent work

Extra information on the teaching methods

- The seminars give more insight in the topics discussed in the lectures, and permit to apply the theoretical concepts to practical examples.
- The practical courses (lab sessions) offer the possibility to get practical insight in theoretical concepts and to get hands-on experience with certain deposition and characterization techniques discussed in the lectures.
- Selected applications of thin films may be addressed via a seminar by a guest lecturer from the work field.

Study material

Type: Syllabus

Name: Course Thin Films: Atomic Scale Processing and Analysis

Indicative price: Free or paid by faculty

Optional: no

Language : English

Available on Ufora : Yes

Type: Slides

Name: Slides

Indicative price: Free or paid by faculty

Optional: no

Language : English

Available on Ufora : Yes

Type: Other

Name: Scientific articles and book chapters

Indicative price: Free or paid by faculty

Optional: no

Language : English

Available on Ufora : Yes

References

- Thin-Film Deposition: Principles and Practice (D. Smith, ISBN: 978-0070585027)
- Materials Science of Thin Films (M. Ohring, ISBN: 9780125249751)
- Handbook of Deposition Technologies for Films and Coatings (P. Martin, ISBN: 9780815520313)
- Glow Discharge Processes: Sputtering and Plasma Etching (B. Chapman ISBN: 978-0-471-07828-9)

Course content-related study coaching

Individual explanations by instructors, by appointment.

Assessment moments

end-of-term and continuous assessment

Examination methods in case of periodic assessment during the first examination period

Written assessment open-book

Examination methods in case of periodic assessment during the second examination period

Written assessment open-book

Examination methods in case of permanent assessment

Presentation

Possibilities of retake in case of permanent assessment

not applicable

Extra information on the examination methods

Periodic evaluation:

- First examination period: Open book examination
- Second examination period: Open book examination

Non-periodic evaluation:

Give a presentation on a modern deposition- or characterization method or thin film application.

Calculation of the examination mark

Average score calculated based on the outcome per question of the open book exam (13/20).

Results on the non-periodic evaluation (7/20).